Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/679,290	SHISHIDO ET AL.	
Examiner	Art Unit	
Alex Liew	2624	

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
382/141-152,154 limited to text search	3/7/2007	AL	
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